

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 246188US2SRD DIV		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT					
		Tatsuo SAISHU, et al.					
		FILING DATE Herewith		GROUP			
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>J.L.</i>	AA	US-5,561,441	10/1996	Hamano			
<i>J.L.</i>	AB	US-6,172,662	1/2001	Ito et al.			
<i>J.L.</i>	AC	US-6,496,170	12/2002	Yoshida et al.			
<i>J.L.</i>	AD	US-6,577,289	06/2003	Asao et al.			
<i>J.L.</i>	AE	US-5,920,301	7/6/1999	K. Sakamoto, et al.			
	AF						
	AG						
	AH						
	AI						
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	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO	2000-10076	1/14/01	Japan	YES	NO	X
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
<i>J.L.</i>	AW	Yasufumi ASAOKA, et al., "Novel Ferroelectric Liquid Crystal Mode for Active Matrix Liquid Crystal Display Using Cholesteric-Chiral Smectic C Phase Transition Material", Jpn. J. Appl. Phys. Vol. 38, Part 1, No. 10, October 1999, pgs. 5977-5983					
<i>J.L.</i>	AX	Jürg FÜNFSCHILLING, et al., "Physics and Electronic Model of Deformed Helix Ferroelectric Liquid Crystal Displays", Jpn. J. Appl. Phys. Vol. 33, Part 1, No. 9A, September 1994, pgs. 4950-4959					
<i>J.L.</i>	AY	A.G.H. VERHULST, et al., "A Wide Viewing Angle Video Display Based on Deformed Helix Ferroelectric LC and a Diode Active Matrix", Conference Record of the International Display Research Conference (IDRC '94), pgs. 377-380					
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner	<i>Jen-Ji Fan</i>				Date Considered <i>11/12/04</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 246188US2SRD DIV	SERIAL NO. 10/751,505		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Tatsuo SAISHU, et al.					
		FILING DATE January 6, 2004	GROUP 2871				
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
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	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
<i>L.L.</i>	AO	08-095001	04/12/96	Japan (with English Abstract)	YES		X
<i>L.L.</i>	AP	1998-080210	11/25/98	Korea (corresponds to JP 09-061030, with English Abstract)			X
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Lun -y- Jia</i>				Date Considered 11/12/04			

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SHEET 1 OF 1

Form PTO 1449  
(Modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

ATTY DOCKET NO.  
246188US2SRDDIV

SERIAL NO.  
10/751,505

APPLICANT

Tatsuo SAISHU, et al.

FILING DATE

January 6, 2004

GROUP

2871

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
L-L	AA	2003/0107538 A1	06/12/2003	Y. ASAOKA, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
L-L	AO	2000-338464	12/08/2000	JAPAN (with English Abstract and corr. US 2003/0107538)		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AW	
AX	
AY	
AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

*Tom J. Faw*

Date Considered

*11/12/04*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.